PRELIMINARY Notice: This is not a final specification.

Some parametric limits are subject to change

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5W816 is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance 0.18µm CMOS technology.

The M5M5W816 is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

M5M5W816WG is packaged in a CSP (chip scale package), with the outline of 7.5mm x 8.5mm, ball matrix of 6 x 8 (48ball) and ball pitch of 0.75mm. It gives the best solution for a compaction

of mounting area as well as flexibility of wiring pattern of printed circuit boards.

Those are summarized in the part name table below.

FEATURES

- Single 2.7~3.0V power supply
- Small stand-by current: 0.1µA (2V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Process technology: 0.18µm CMOS
- Package: 48ball 7.5mm x 8.5mm CSP

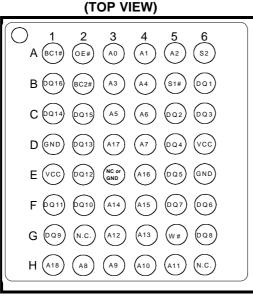
Version,				Stand-by current						Activ e
Operating	Part name	Power	Access time max.	* Typical		Ratings (max.))	current
temperature		Supply		25°C	40°C	25°C	40°C	70°C	85°C	lcc1 * (typ.)
I-version -40 ~ +85°C	M5M5W816WG - 85HI	2.7 ~ 3.0V	85ns	0.5	1.0	2	4	20	40	40mA (10MHz) 10mA (1MHz)

* Typical parameter indicates the value for the

center

of distribution, and is not 100% tested.

PIN CONFIGURATION



Pin	Function				
A0 ~ A18	Address input				
DQ1 ~ DQ16	Data input / output				
S1#	Chip select input 1				
S2	Chip select input 2				
W#	Write control input				
OE#	Output enable input				
BC1#	Lower Byte (DQ1 ~ 8)				
BC2#	Upper Byte (DQ9~16)				
Vcc	Power supply				
GND	Ground supply				

Outline : 48F7Q

NC : No Connection

*Don't connect E3 ball to voltage level more than 0V



MITSUBISHI ELECTRIC



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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

FUNCTION

The M5M5W816WG is organized as 524288-words by 16-bit. These devices operate on a single +2.7~3.0V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S1#, S2 , W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1# and S2 are in an active state(S1#=L,S2=H).

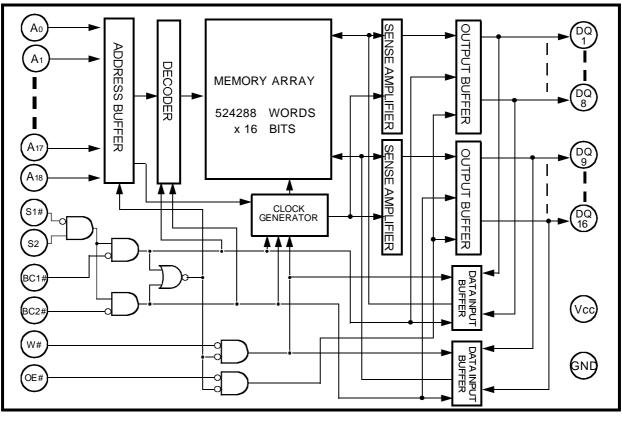
When setting BC1# at the high level and other pins are in an active stage , upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a nonselectable mode. When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as $0.1\mu A(25^{\circ}C, typical)$, and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

S1#	S2	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~16	lcc
Н	L	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
L	L	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
Н	Н	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
Х	Х	Н	Н	Х	Х	Non selection	High-Z	High-Z	Standby
L	Н	L	Н	L	Х	Write	Din	High-Z	Active
L	Н	L	Н	Н	L	Read	Dout	High-Z	Active
L	Н	L	Н	Н	Н		High-Z	High-Z	Active
L	Н	Н	L	L	Х	Write	High-Z	Din	Active
L	Н	Н	L	Н	L	Read	High-Z	Dout	Active
L	Н	Н	L	Н	Н		High-Z	High-Z	Active
L	Н	L	L	L	Х	Write	Din	Din	Active
L	Н	L	L	Н	L	Read	Dout	Dout	Active
L	Н	L	L	Н	Н		High-Z	High-Z	Active

BLOCK DIAGRAM







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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
Vcc	Supply voltage	With respect to GND	-0.3* ~ +4.6	
Vı	Input voltage	With respect to GND	-0.3* ~ Vcc + 0.3 (max. 4.6V)	V
Vo	Output voltage	With respect to GND	0 ~ Vcc	
Pd	Power dissipation	Ta= 25°C	700	mW
Ta	Operating temperature		- 40 ~ +85	°C
Tstg	Storage temperature		- 65 ~ +150	°C

* -3.0V in case of AC (Pulse width \leq 30ns)

DC ELECTRICAL CHARACTERISTICS

(Vcc=2.7 ~ 3.0V, unless otherwise noted)

Quarter		Parameter Conditions			Limits	;	
Symbol	Parameter			Min	Тур	Max	Units
Vін	High-lev el input voltage			2.2		Vcc+0.2V	
VIL	Low-lev el input voltage			-0.2 *		0.6	
Vон	High-level output voltage	Іон= -0.5mA		2.4			V
Vol	Low-lev el output voltage	Iol=2mA				0.4	
h	Input leakage current	VI=0 ~ Vcc				±1	μA
lo	Output leakage current	BC1# and BC2# =VIH or S1# =VIH or S2=VIL or OE#	=VIH, VI/O=0 ~ Vcc			±1	μΑ
lcc1	Active supply current	BC1# and BC2# <u>≤</u> 0.2V, S1# <u>≤</u> 0.2V, S2 <u>≥</u> Vcc-0.2V other inputs <u>≤</u> 0.2V or <u>≥</u> Vcc-0.2V Output - open (duty 100%)	f= 10MHz	-	30	40	
ICCT	(AC,MOS level)		f= 1MHz	-	5	10	
	Active supply current	BC1# and BC2#=VIL , S1#=VIL ,S2=VIH other pins =VIH or VIL	f= 10MHz	-	30	40	mΑ
lcc2	(AC,TTL level)	Output - open (duty 100%)	f= 1MHz	-	5	10	
		 (1) S1# ≥ Vcc - 0.2V, S2 ≥ Vcc - 0.2V, 	~ +25°C	-	0.5	2	
1002	Stand by supply current	other inputs = $0 \sim Vcc$ (2) S2 $\leq 0.2V$,	~ +40°C	-	1.0	4	
Icc3	(AC,MOS level)	other inputs = $0 \sim Vcc$ (3) BC1# and BC2# $\geq Vcc - 0.2V$	~ +70°C	-	-	20	μA
		$S1\# \leq 0.2V, S2 \geq Vcc - 0.2V$ other inputs = 0 ~ Vcc	~ +85°C	-	-	40	
lcc4	Stand by supply current (AC,TTL level)	BC1# and BC2# =VIH or S1# =VIH or S2=VIL Other inputs= 0 ~ Vcc		-	-	2	mA

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

* -3.0V in case of AC (Pulse width \leq 30ns)

Note 2: Typical parameter indicates the value for the center of distribution, and is not 100% tested.

CAPACITANCE

(Vcc=2.7 ~ 3.0V, unless otherwise noted)

Svr	abo Daramatar	Conditions		Limits	5	
Syr	Symbo Parameter	Conditions	Min	Тур	Max	Units
С	Input capacitance	VI=GND, VI=25mVrms, f=1MHz			10	pF
С	o Output capacitance	Vo=GND,Vo=25mVrms, f=1MHz			10	μL



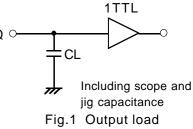


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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

AC ELECTRICAL CHARACTERISTICS (Vcc=2.7 ~ 3.0V, unless otherwise noted) (1) TEST CONDITIONS

Supply voltage	2.7~3.0V	
Input pulse	VIH=2.4V, VIL=0.4V	DQ O-
Input rise time and fall time	5ns	
Reference level	Voh=Vol=1.5V Transition is measured ±200mV from steady state voltage.(for ten,tdis)	
Output loads	Fig.1,CL=30pF	
Output loudo	CL=5pF (for ten.tdis)	



(2) READ CYCLE

		Lir	Limits			
Symbol	Parameter	Min	Max	Units		
tcr	Read cycle time	85		ns		
t _a (A)	Address access time		85	ns		
t _a (S1)	Chip select 1 access time		85	ns		
ta(S2)	Chip select 2 access time		85	ns		
ta(BC1)	Byte control 1 access time		85	ns		
ta(BC2)	Byte control 2 access time		85	ns		
ta(OE)	Output enable access time		45	ns		
tdis(S1)	Output disable time after S1# high		30	ns		
tdis(S2)	Output disable time after S2 low		30	ns		
tdis(BC1)	Output disable time after BC1# high		30	ns		
tdis(BC2)	Output disable time after BC2# high		30	ns		
tdis(OE)	Output disable time after OE# high		30	ns		
t _{en} (S1)	Output enable time after S1# low	10		ns		
ten(S2)	Output enable time after S2 high	10		ns		
tdis(BC1)	Output enable time after BC1# low	5		ns		
tdis(BC2)	Output enable time after BC2# low	5		ns		
ten(OE)	Output enable time after OE# low	5		ns		
t∨(A)	Data valid time after address	10		ns		

(3) WRITE CYCLE

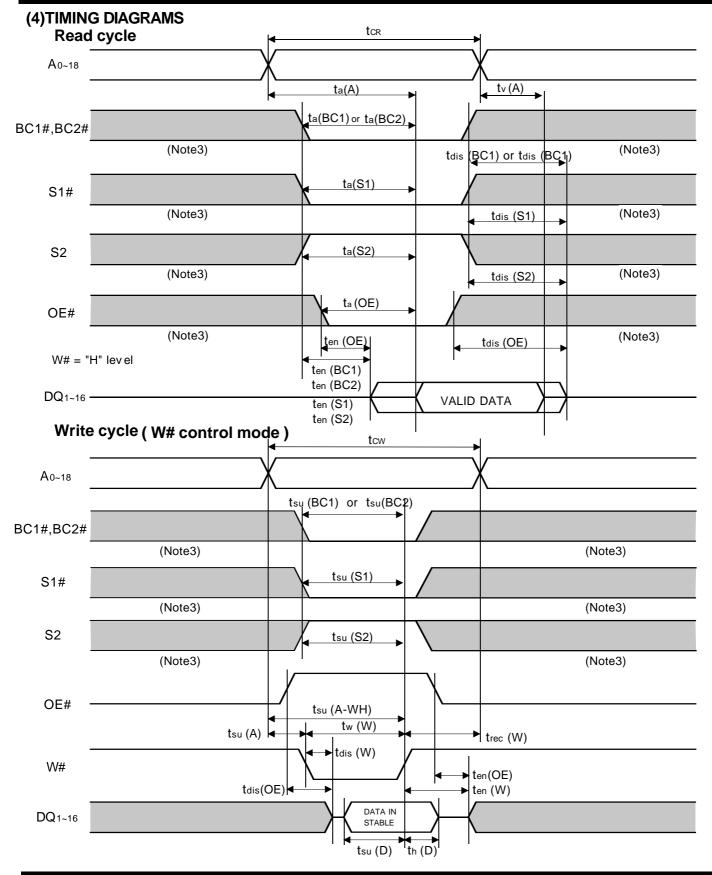
		Li	Limits			
Symbol	Parameter	Min	Max	- Units		
tcw	Write cycle time	85		ns		
t _w (W)	Write pulse width	60		ns		
tsu(A)	Address setup time	0		ns		
tsu(A-WH)	Address setup time with respect to W#	70		ns		
tsu(BC1)	Byte control 1 setup time	70		ns		
tsu(BC2)	Byte control 2 setup time	70		ns		
tsu(S1)	Chip select 1 setup time	70		ns		
tsu(S2)	Chip select 2 setup time	70		ns		
tsu(D)	Data setup time	45		ns		
th(D)	Data hold time	0		ns		
trec(W)	Write recovery time	0		ns		
tdis(W)	Output disable time from W# low		30	ns		
tdis(OE)	Output disable time from OE# high		30	ns		
ten(W)	Output enable time from W# high	5		ns		
ten(OE)	Output enable time from OE# low	5		ns		





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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

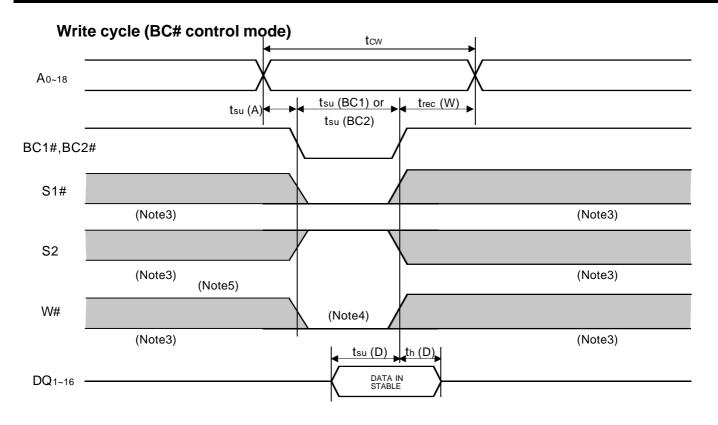






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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM



Note 3: Hatching indicates the state is "don't care".

Note 4: A Write occurs during S1# low, S2 high overlaps BC1# and/or BC2# low and W# low.

Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.

Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.



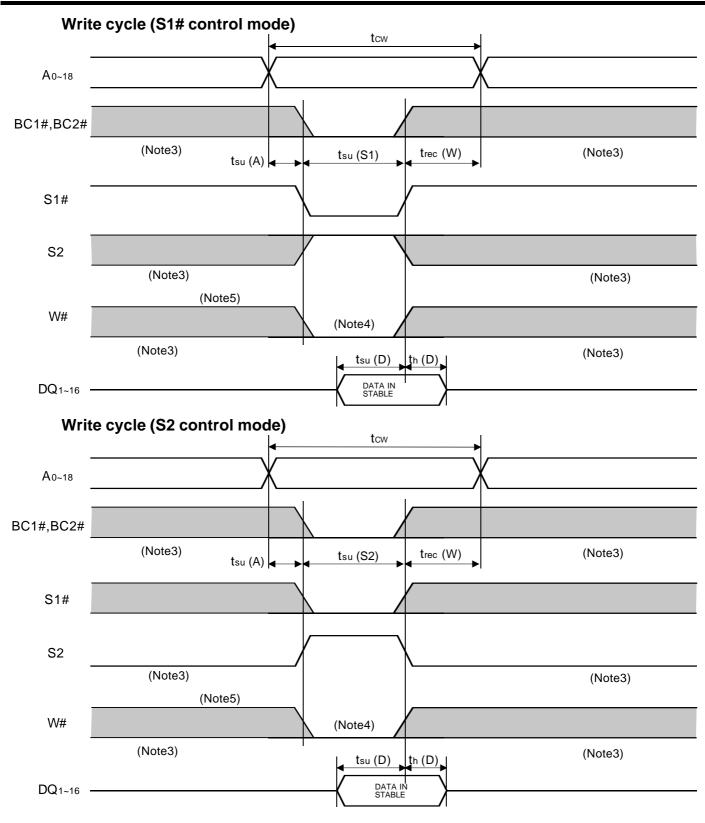
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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM





8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS

Symbol Decemptor		—	Test see differen		Limits		
Symbol	Parameter	Test conditions	l est conditions		Тур	Max	Units
Vcc (PD)	Power down supply voltage			2.0			V
VI (BC#) Byte control input BC1# &	2.2V≦ Vcc(PD)		2.0				
	BC2#	2.0V≦ Vcc(PD)≦2.2V			Vcc(PD)		V
	2.2V≦ Vcc(PD)		2.0				
VI (S1#)	Chip select input S1#	$2.0V \leq Vcc(PD) \leq 2.2V$			Vcc(PD)		V
VI (S2)	Chip select input S2					0.2	
		Vcc=2.0V (1) S1# ≥ Vcc - 0.2V,	~ +25°C	-	0.1	1.5	
ICC (PD)	Power down	other inputs = $0 \sim Vcc$ (2) S2 $\leq 0.2V$,	~ +40°C	-	0.2	3	
supply current	other inputs = 0 ~ Vcc (3) BC1# and BC2# \geq Vcc - 0.2V	~ +70°C	-	-	15	μA	
		$S1\# \leq 0.2V$, $S2 \geq Vcc - 0.2V$ other inputs = 0 ~ Vcc	~ +85°C	-	-	30	

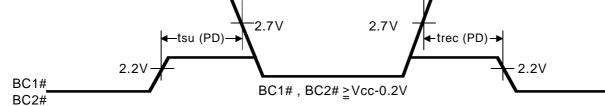
(2) TIMING REQUIREMENTS

Note 2: Typical parameter of Icc(PD) indicates the value for the center of distribution, and is not 100% tested.

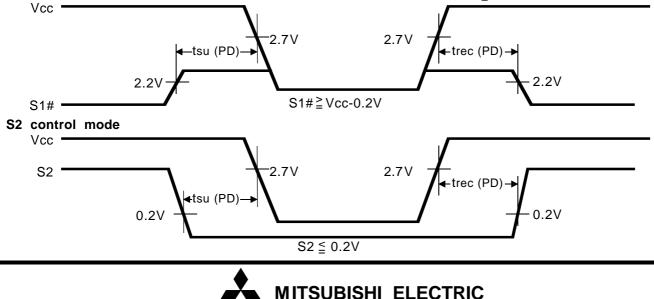
Symbol	Parameter					
		Test conditions	Min	Тур	Max	Units
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

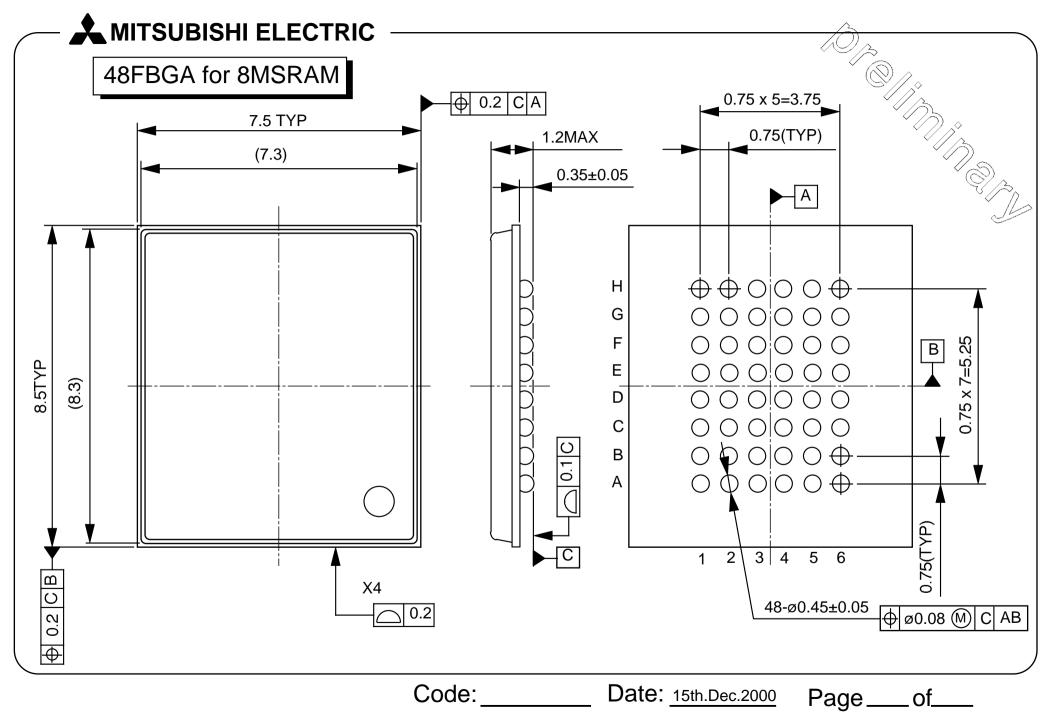
(3) TIMING DIAGRAM

BC# control mode On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2 \geq Vcc-0.2V or S2 \leq 0.2V Vcc



S1# control mode On the S1# control mode, the level of S2 must be fixed at S2 \geq Vcc-0.2V or S2 \leq 0.2V





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